


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522586	<b>Applicant(s)/Patent Under Reexamination</b>  VON STEIN ET AL.
	<b>Examiner</b>  SHAQ TAHA	<b>Art Unit</b>  2446

SEARCHED			
Class	Subclass	Date	Examiner
709	218	08/28/2008	S. Taha
709	218	02/20/2009	S. Taha
709	218	09/08/2009	S. Taha

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709.	08/28/2008	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/217,223,224,225,226,227,	02/20/2009	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/217,223,224,225,226,227	09/08/2009	S. Taha

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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